

DIFFRACTION

CHAPTER 36



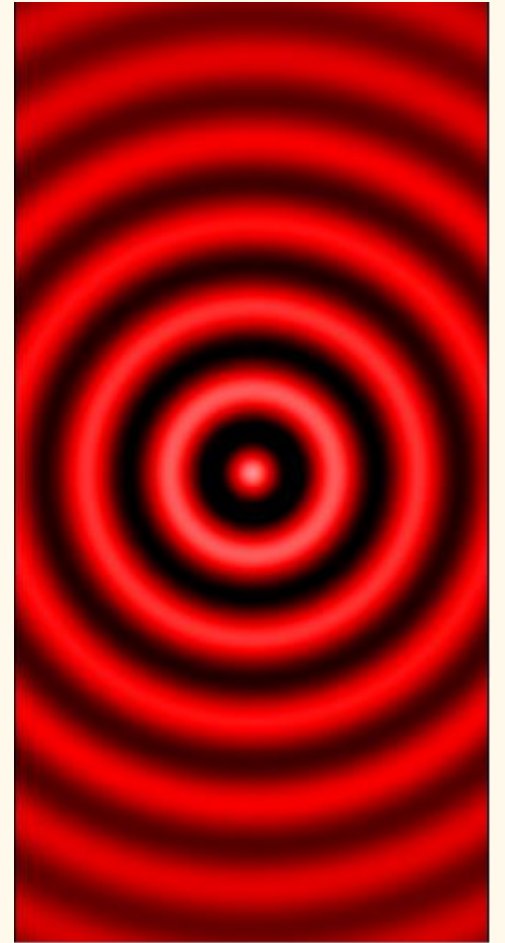
Picture from James Webb telescope

- Electromagnetic Oscillations & Alternating Current
- Maxwell's Equations & Magnetism of Matter
- Electromagnetic Waves
- Images
- Interference
- **Diffraction**

DIFFRACTION

Textbook: Chapter 36

- SINGLE-SLIT DIFFRACTION
- DIFFRACTION BY A CIRCULAR APERTURE
- DIFFRACTION BY A DOUBLE SLIT
- DIFFRACTION GRATINGS
- X-RAY DIFFRACTION



SINGLE-SLIT DIFFRACTION

Geometrical optics:

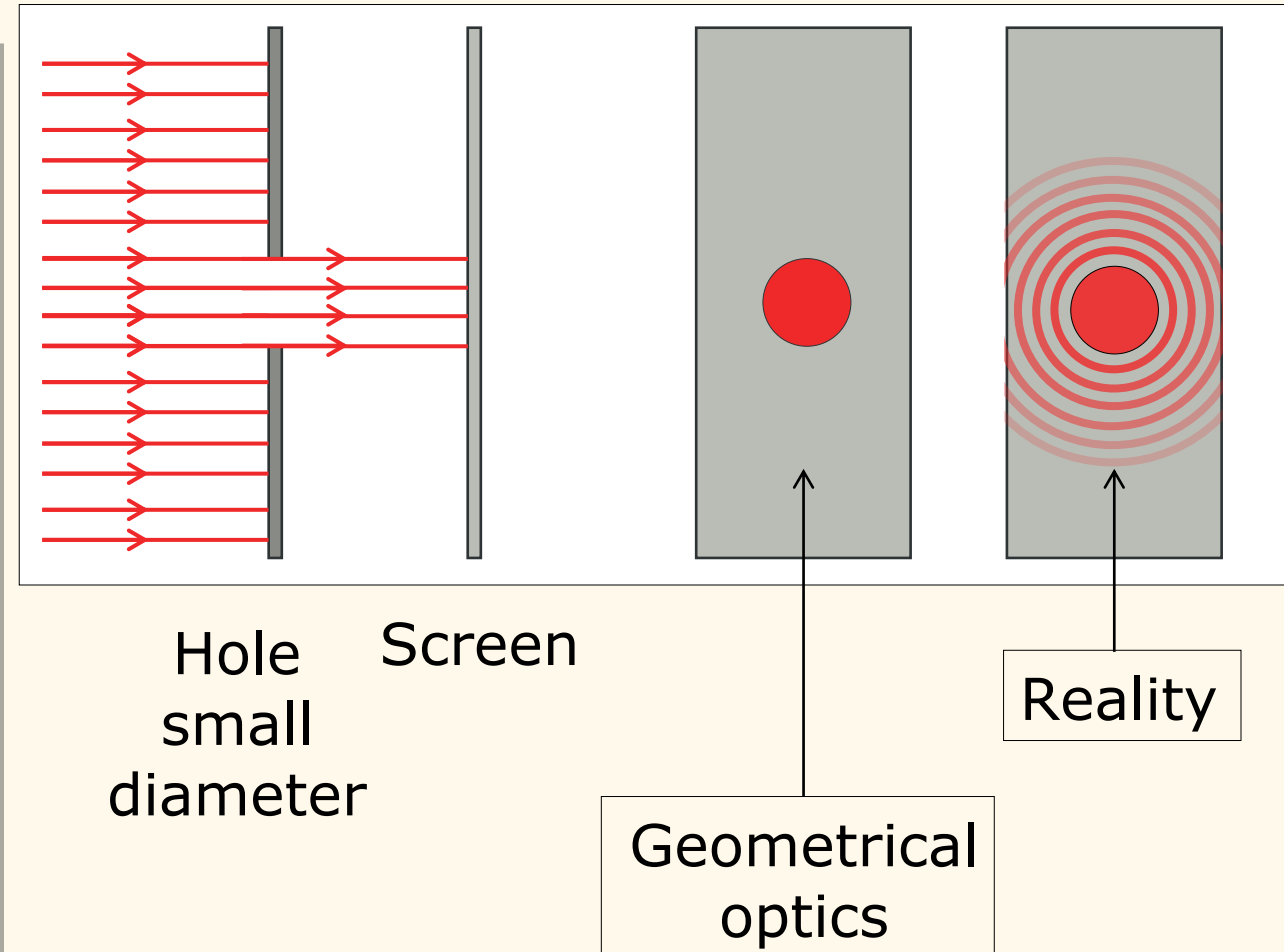
Light = Rays → Straight lines

Beams can be forever as narrow as we want

Reality:

After small apertures or objects **spreading + fringes**

→ Like interference, geometrical optics cannot describe the phenomena



SINGLE-SLIT DIFFRACTION

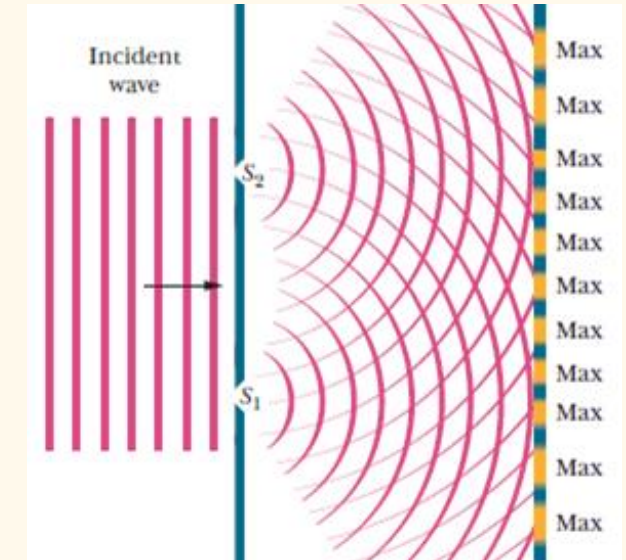
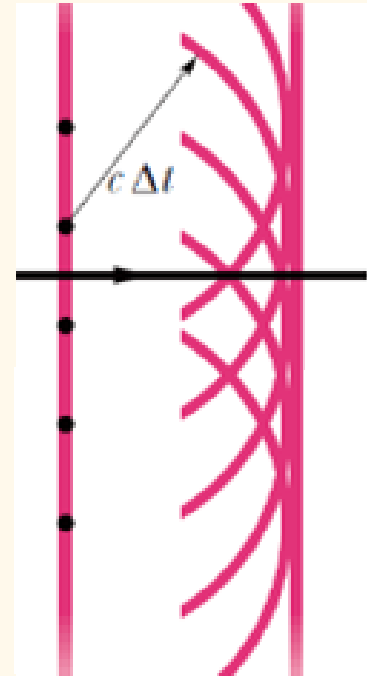
Diffraction

→ Explained by light as **EM wave**

Last chapter: We explained interference with **slits of width comparable to λ**

→ Source of 1 half-spherical wavelet following Huygens' Principle

→ Fringes on **all the screen** (in theory)



Double-slit interference
Width $\sim \lambda$

Generalization to objects of **any width**
→ source of **multiple wavelets**
Interference pattern not infinite

SINGLE-SLIT DIFFRACTION

Diffraction by a single slit



Ken Kay/Fundamental Photographs

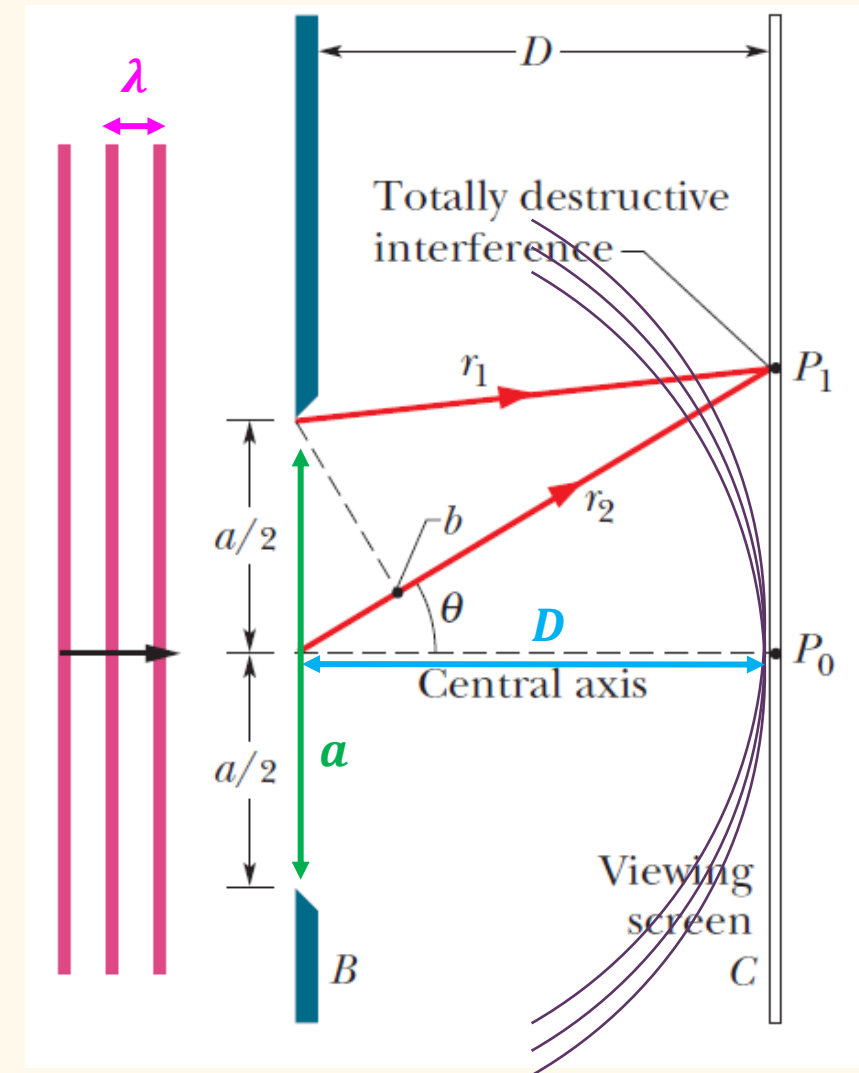
How to explain this pattern ?

→ Large bright center
+ dark / bright fringes

Slit of width a a screen at distance D
We assume $D \gg a > \lambda$

Bright center: wavelets travel
~ the same distance to reach P_0
→ In phase
→ **Constructive** interference

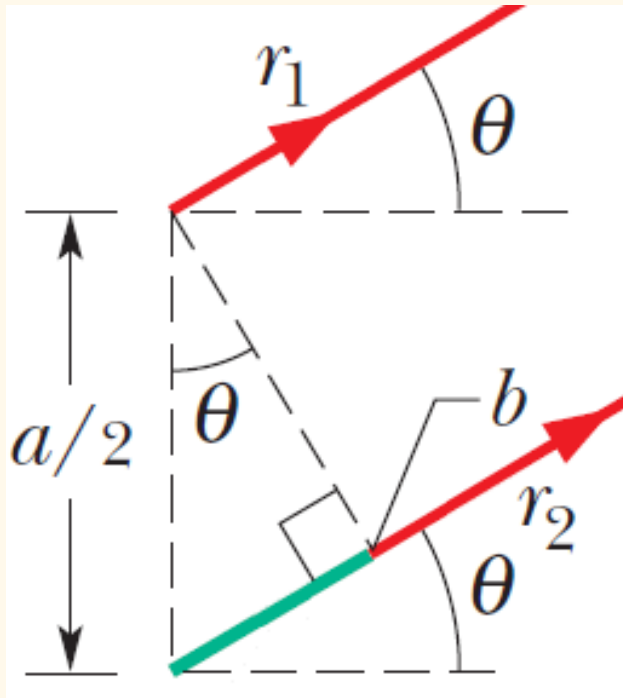
Dark fringes: Wavelets out of phase
→ **Destructive** interference



SINGLE-SLIT DIFFRACTION

Position of the dark fringes: **1st minimum P_1**

→ Strategy = Pairing rays spaced by $a/2$ and **finding the condition** for destructive interference



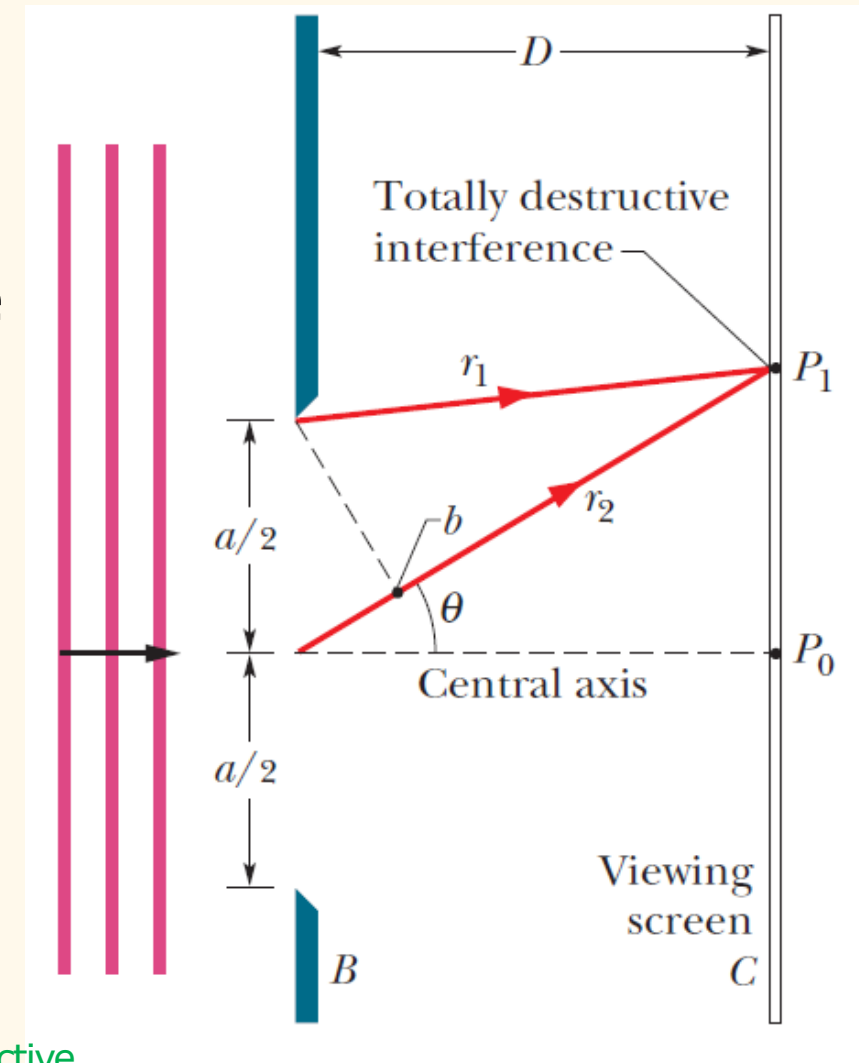
We assume **$D \gg a$**

→ Rays parallel close to the slit – angle θ to reach P_1

→ Difference of path

$$\frac{a}{2} \sin \theta \longrightarrow \frac{\lambda}{2}$$

condition for destructive interference

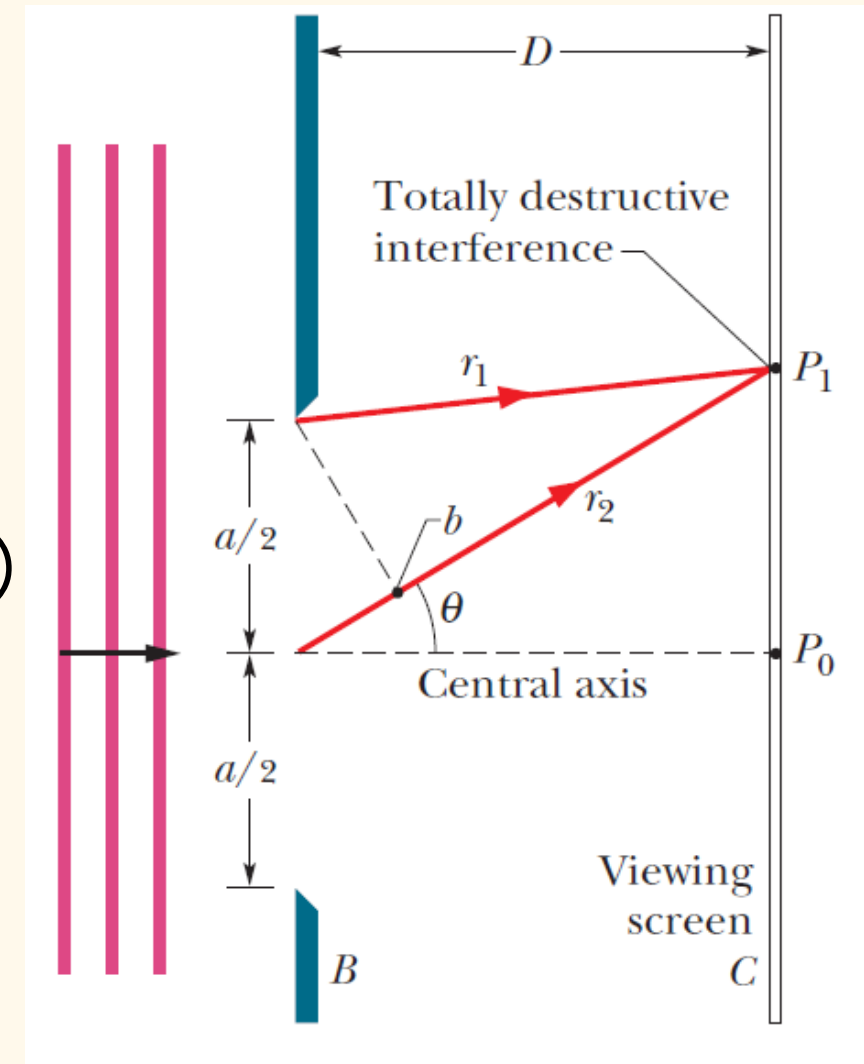


SINGLE-SLIT DIFFRACTION

Position of the dark fringes: **1st minimum P_1**
→ Every pair of rays spaced by $a/2$ going to P_1
satisfy: $a \sin \theta = \lambda$

Note: If we decrease a → $\sin \theta$ increases (λ is cst)
→ θ increases
→ Pattern is enlarged

→ Other minimums ?



SINGLE-SLIT DIFFRACTION

Position of the dark fringes: 2nd minimum P_2

→ Group of 4 rays spaced by $a/4$ going to P_2

$$(a/4) \sin\theta = \lambda/2 \longrightarrow a \sin\theta = 2\lambda$$

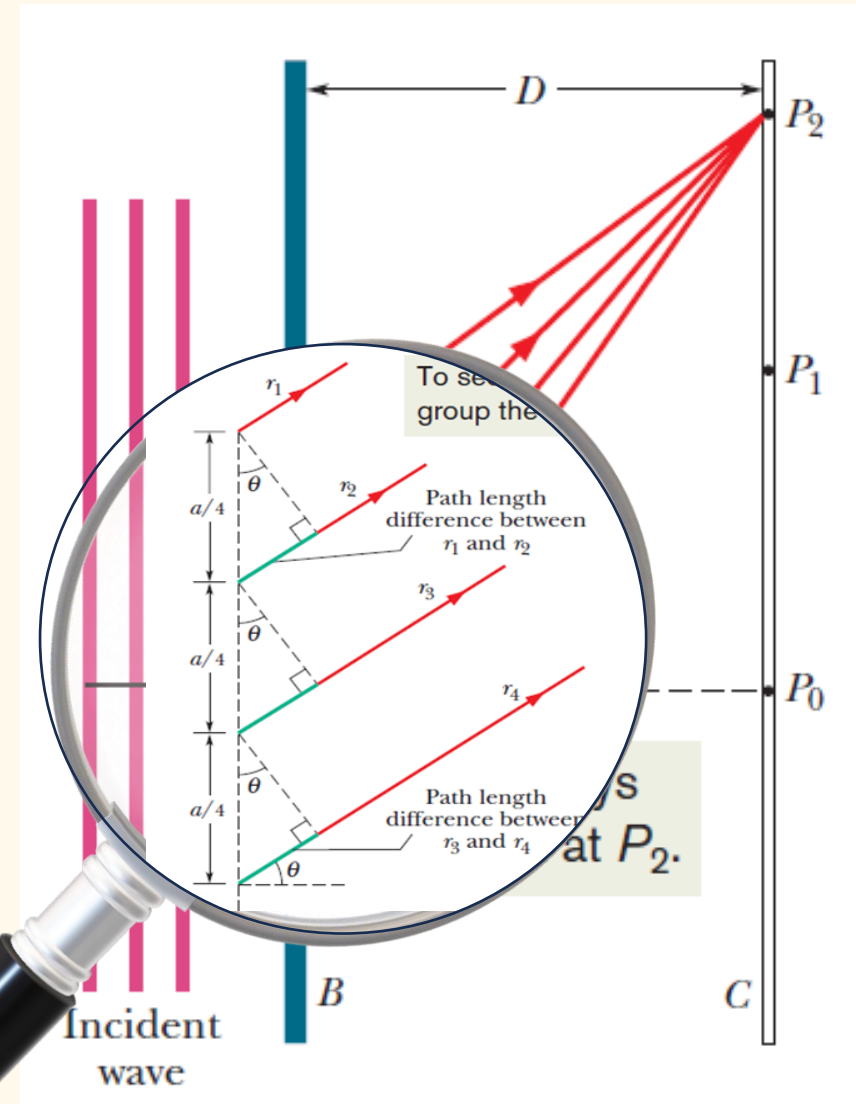
Position of the dark fringes: m^{th} minimum P_m

→ Group of m rays spaced by $a / 2m$ going to P_m

$$(a/2m) \sin\theta = \lambda/2 \longrightarrow a \sin\theta = m\lambda$$

θ satisfying: $a \sin\theta = m\lambda$ (m integer > 1)

→ Dark fringe at angle θ



SINGLE-SLIT DIFFRACTION

Intensity profile

General problem: finding the intensity at every angle θ to point P

→ Slit divided into N zones of width Δx

→ Each is source of a wavelet

Need to determine E_θ : the field at P to calculate intensity

Phase difference between 2 adjacent wavelets: $\Delta\phi = \frac{2\pi}{\lambda} (\Delta x \sin\theta)$

$$E_\theta = \sum \Delta E \sin(kx - \omega t + \phi)$$

Sum of ΔE \sin kx $-\omega t + \phi$
Amplitude of each wavelet
projected by the phase factor

Wave number k $\frac{2\pi}{\lambda}$
Difference of path $(\Delta x \sin\theta)$

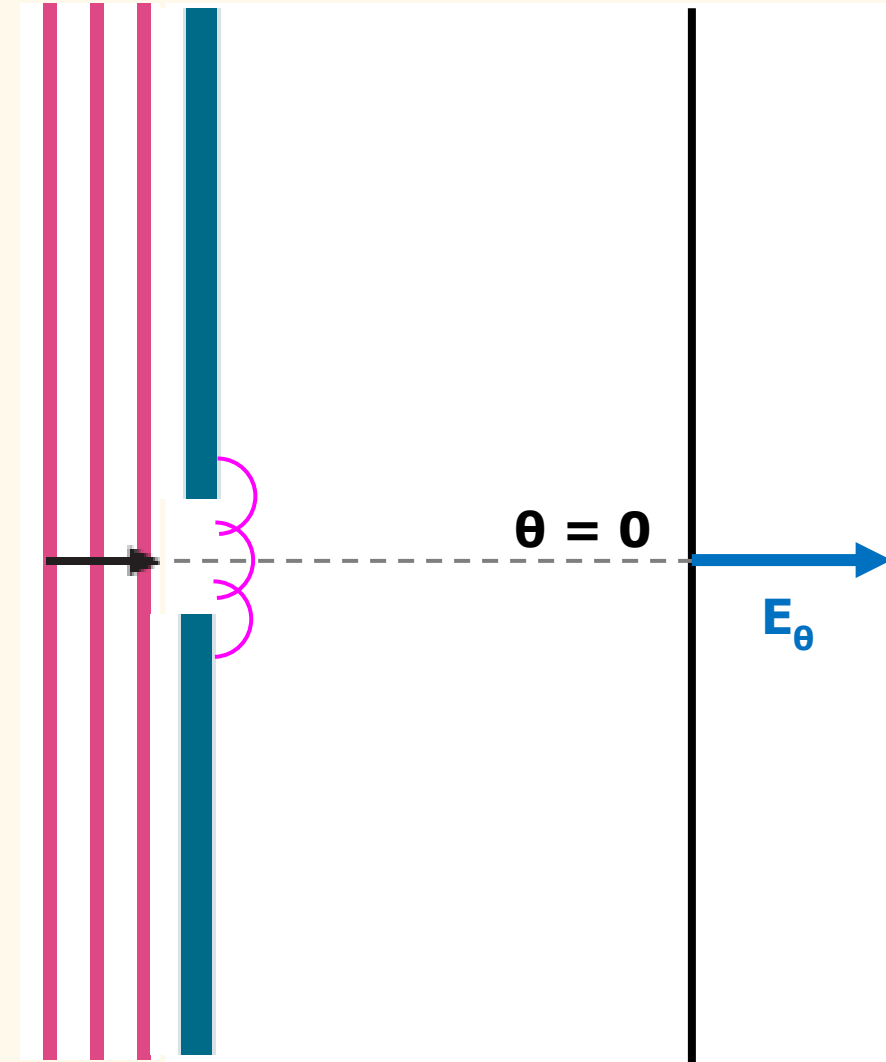
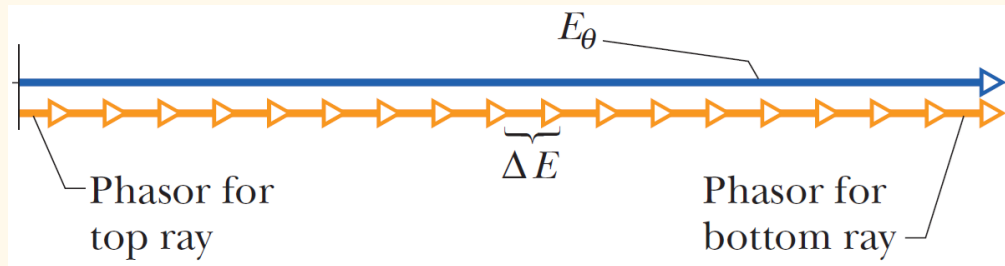
SINGLE-SLIT DIFFRACTION

Intensity profile

$$\Delta\phi = \frac{2\pi}{\lambda} (\Delta x \sin\theta) \quad \text{between 2 adjacent wavelets}$$

- $\theta = 0 \rightarrow \Delta\phi = 0$ for every wavelet**
- \rightarrow All wavelets are in phase
 - \rightarrow **Brightest fringe $E_\theta = N \Delta E$**

Representation with phasors:



SINGLE-SLIT DIFFRACTION

Intensity profile

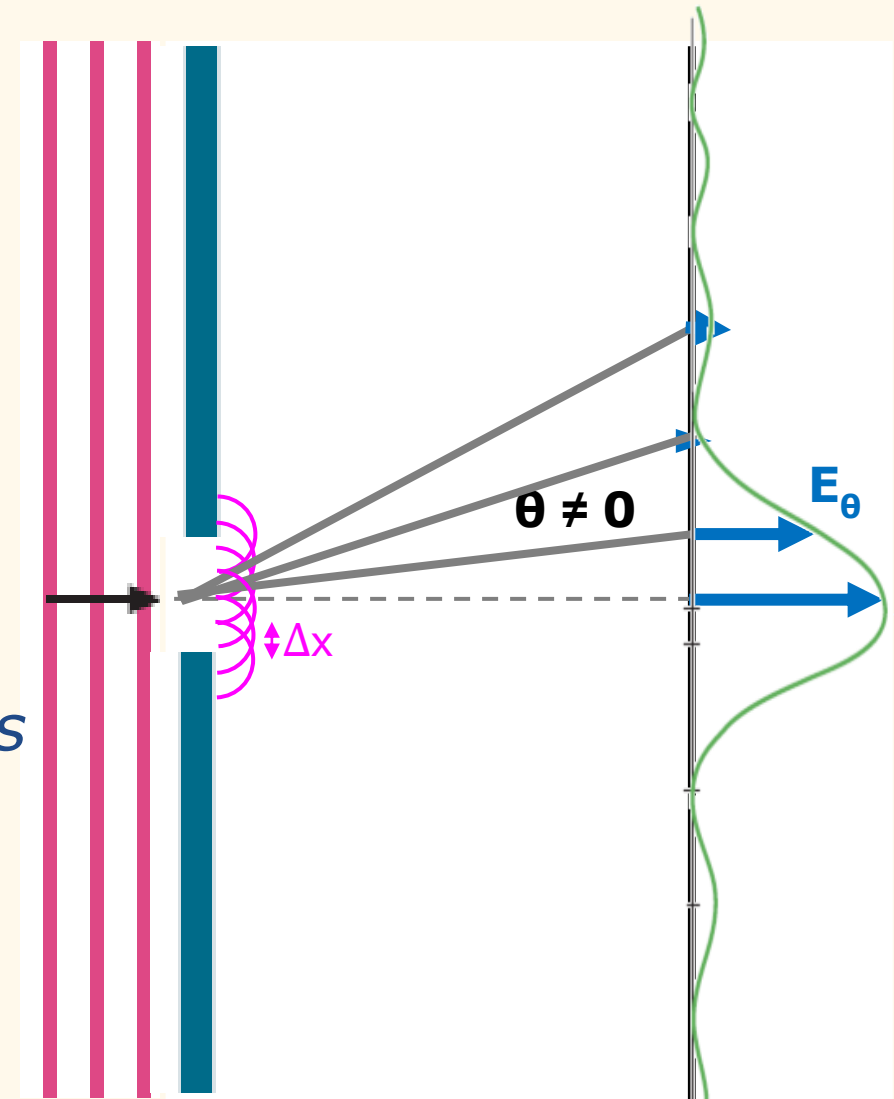
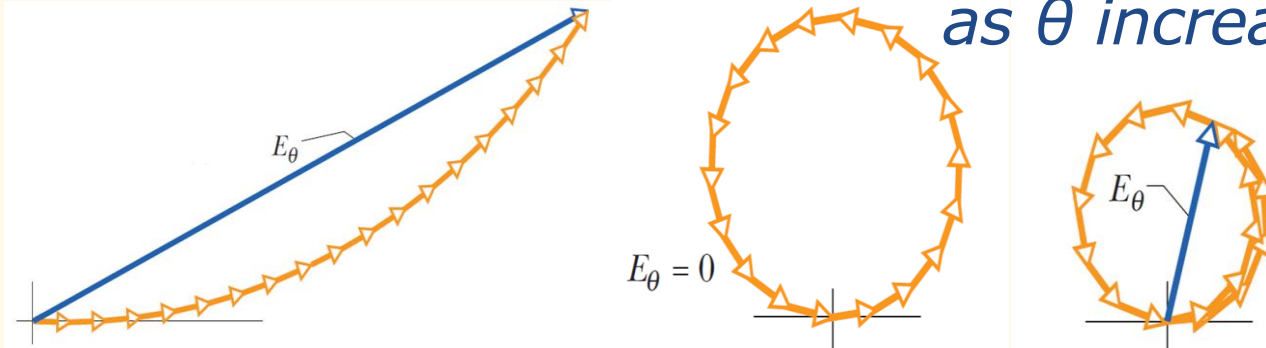
$$\Delta\phi = \frac{2\pi}{\lambda} (\Delta x \sin\theta) \quad \text{between 2 adjacent wavelets}$$

$\theta \neq 0 \rightarrow \Delta\phi \neq 0$ for every wavelet

\rightarrow All wavelets have a phase difference

$\rightarrow \mathbf{E}_\theta \neq N\Delta\mathbf{E}$

Representation with phasors: *spiral on themselves as θ increases*

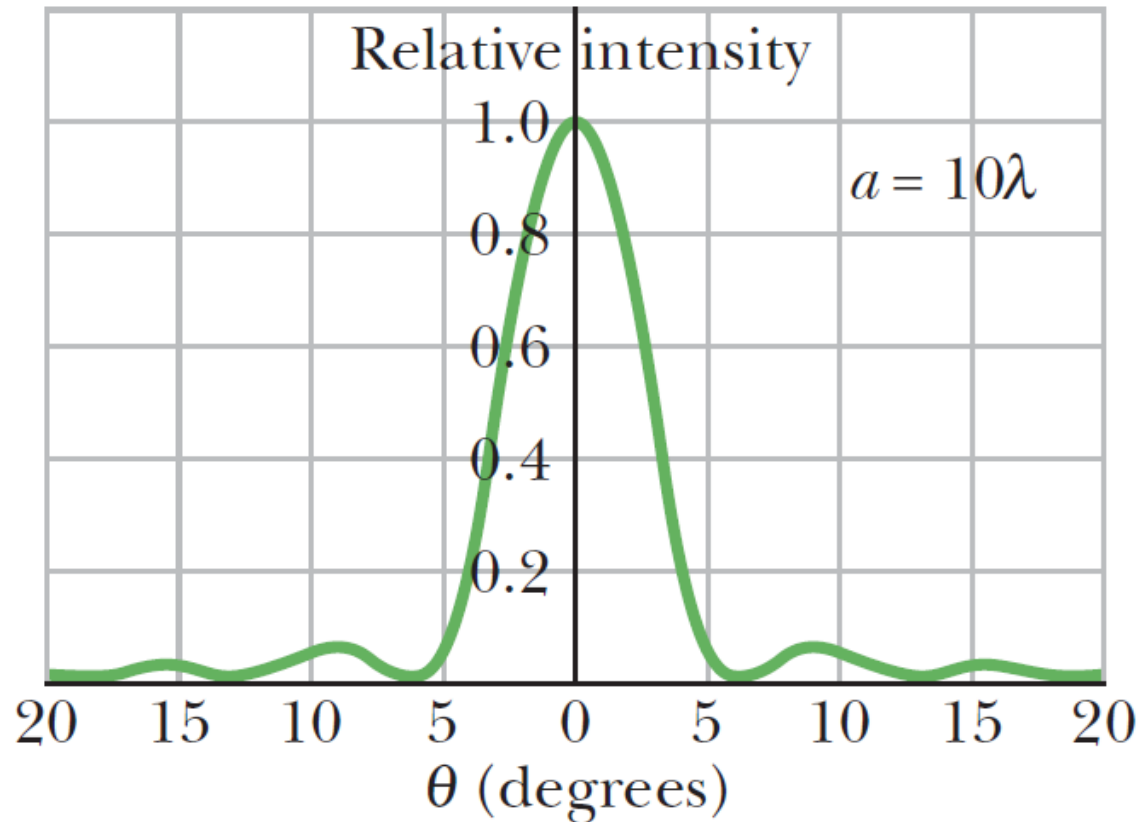


SINGLE-SLIT DIFFRACTION

Intensity profile



Ken Kay/Fundamental Photographs



Typical intensity profile for single-slit diffraction

**As θ increases
 E_θ has zeros
and local maxima
→ The same for intensity**

→ **Analytical expression ?**

SINGLE-SLIT DIFFRACTION

Intensity profile (optional demonstration)

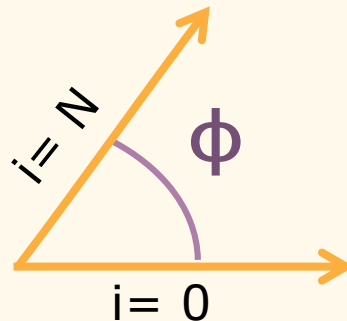
→ Analytical expression

For a given angle θ , the i^{th} of the N phasors has a phase difference with the 1st

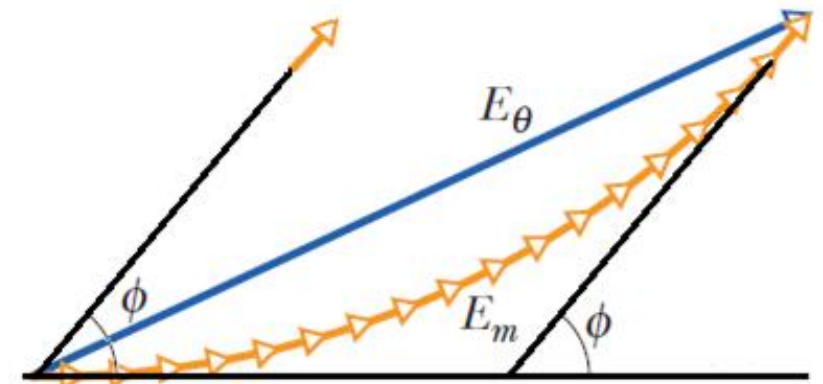
$$\Delta\phi_i = \frac{2\pi}{\lambda} (i\Delta x \sin\theta)$$

We define ϕ as the difference of phase between the 1st ($i=0$) and the last phasor ($i= N$)

$$\phi = \Delta\phi_N - \Delta\phi_0$$



We report ϕ at the intersection of the projections of the 1st and the N^{th} phasors



SINGLE-SLIT DIFFRACTION

Intensity profile (optional demonstration)

→ **Analytical expression**

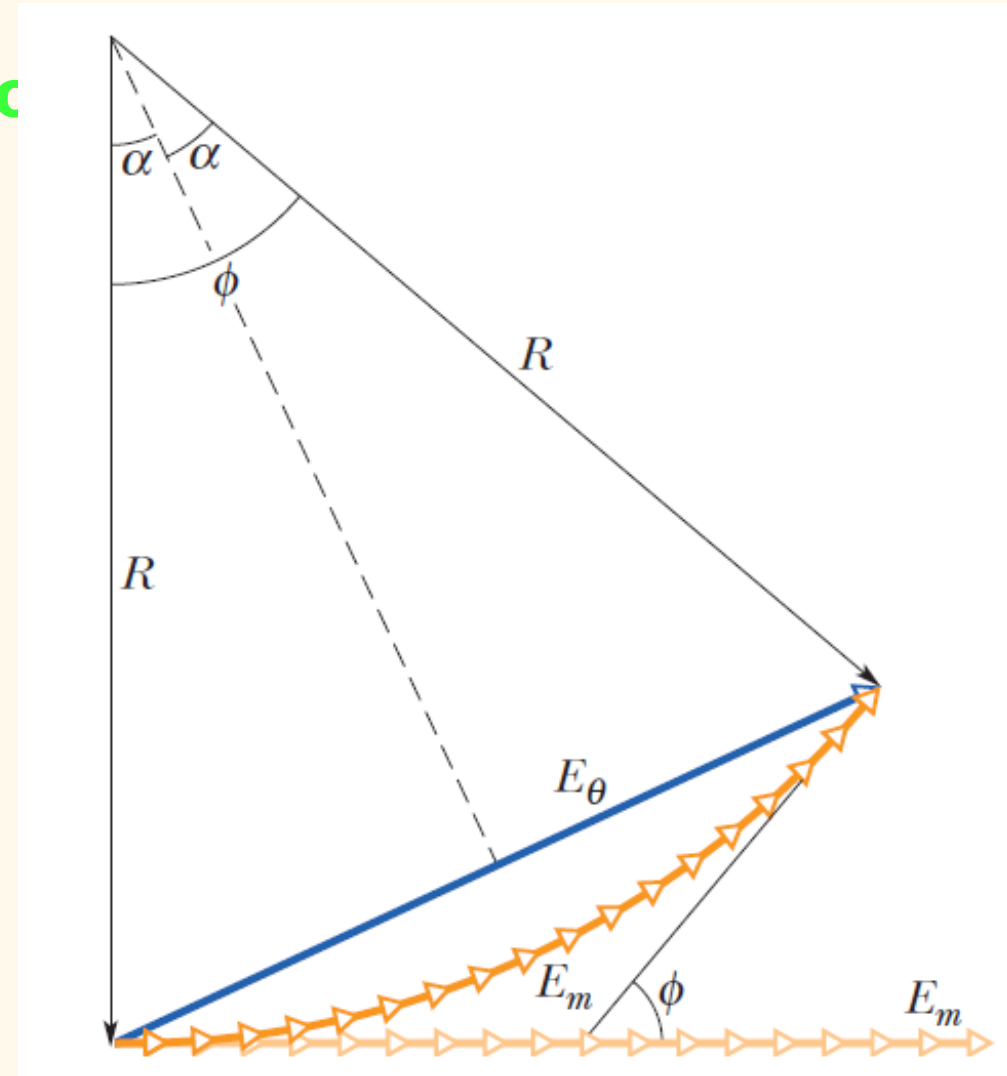
$N \rightarrow \infty$: The sum of the phasors of the wavelets is an arc of circle of radius R .

The length of the arc is always the same

→ = to E_m (when $\theta = 0$)

By construction, ϕ is the angle between the radius

We define $\alpha = \phi/2$



SINGLE-SLIT DIFFRACTION

Intensity profile (optional demonstration)
→ **Analytical expression**

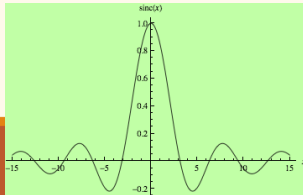
We have: $\sin\alpha = \frac{E_\theta / 2}{R}$

And, in radians: $\phi = 2\alpha = \frac{E_m}{R}$

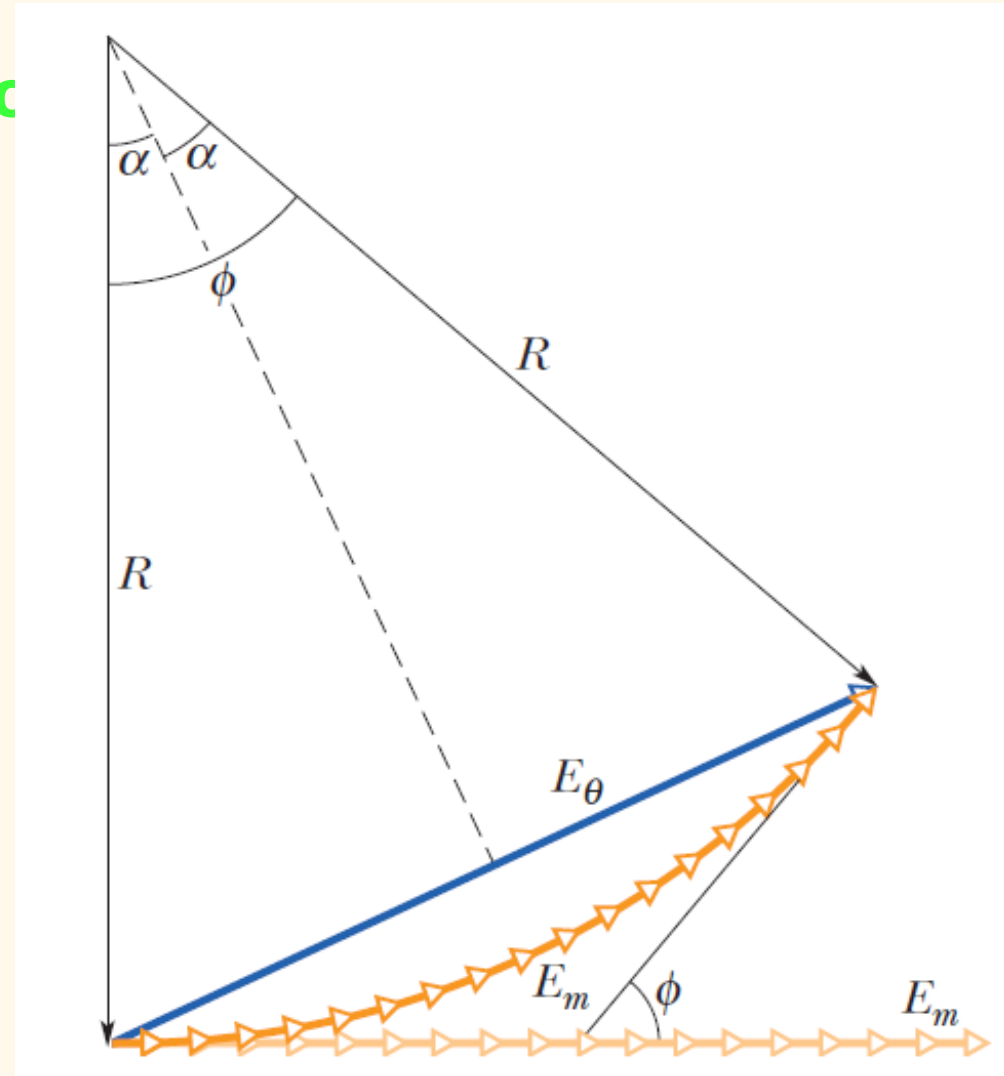
Combining these two expressions:

$$\sin\alpha = \frac{E_\theta / 2}{E_m / (2\alpha)} \longrightarrow E_\theta = E_m \frac{\sin\alpha}{\alpha}$$

Note: $\text{sin}_c(x) = \sin(x) / x$
the sinc function



$$E_\theta = E_m \text{sin}_c\alpha$$



SINGLE-SLIT DIFFRACTION

Intensity profile (optional demonstration)

→ **Analytical expression**

We define the relative intensity as: $I_r = \frac{I_\theta}{I_{\theta=0}} = \frac{I_\theta}{I_m}$

Since the intensity is proportional to the squared length of the phasor:

$$I_r = \frac{E_\theta^2}{E_m^2}$$

$$\text{So } \frac{I_\theta}{I_m} = \frac{E_\theta^2}{E_m^2} \longrightarrow I_\theta = I_m \frac{E_\theta^2}{E_m^2} \text{ with } E_\theta = E_m \sin_c \alpha \longrightarrow \boxed{I_\theta = I_m \sin_c^2 \alpha}$$

Last step: relation between α and θ

SINGLE-SLIT DIFFRACTION

Intensity profile (optional demonstration)

→ Analytical expression

We have: $\Delta\phi_i = \frac{2\pi}{\lambda} (i\Delta x \sin\theta)$, $\phi = \Delta\phi_N - \Delta\phi_0$, $\alpha = \frac{\phi}{2}$ and $I_\theta = I_m \sin_c^2 \alpha$

$$\Delta\phi_{i=0} = 0$$

$$\Delta\phi_{i=N} = \frac{2\pi}{\lambda} (N\Delta x \sin\theta)$$

a = width of the slit,
divided in N intervals Δx ,
so we have: $N\Delta x = a$

$$\Delta\phi_N = \frac{2\pi}{\lambda} (a \sin\theta)$$

$$\phi = \frac{2\pi}{\lambda} (a \sin\theta)$$

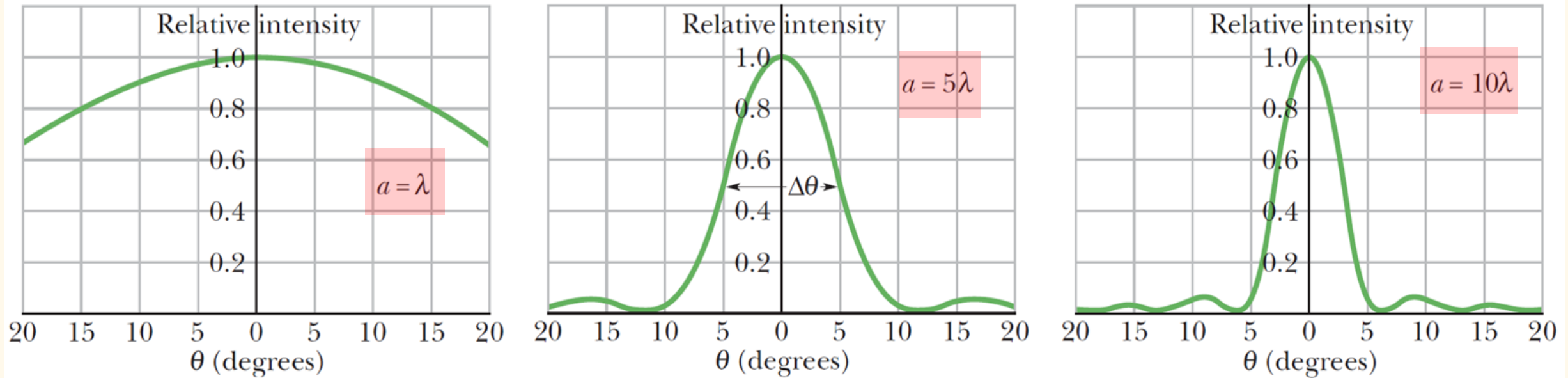
$$\alpha = \frac{\pi}{\lambda} (a \sin\theta)$$

$$I_\theta = I_m \sin_c^2 \left(\frac{a\pi}{\lambda} \sin\theta \right)$$

SINGLE-SLIT DIFFRACTION

Intensity profile

→ **Analytical expression**



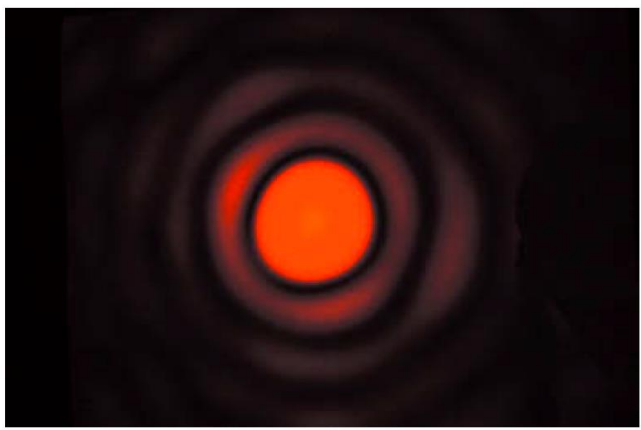
Narrower slit → More spreading
Larger slit → Less spreading

$$I_{\theta} = I_m \sin^2_c \left(\frac{a\pi}{\lambda} \sin\theta \right)$$

DIFFRACTION BY A CIRCULAR APERTURE

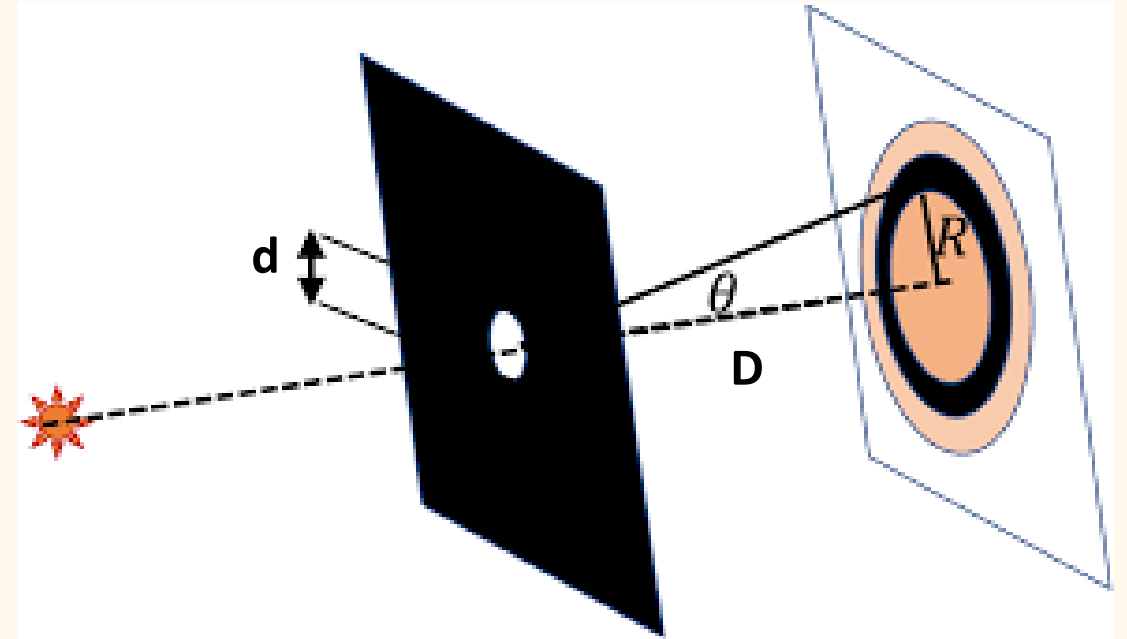
Circular apertures

- A little more analytically complex than slits
- We will admit some results



Courtesy Jearl Walker

Pattern = central disk + fringes



$$\text{First minimum at: } \sin \theta = 1,22 \frac{\lambda}{d}$$

DIFFRACTION BY A CIRCULAR APERTURE

Resolvability

The same result is true for lenses of diameter d

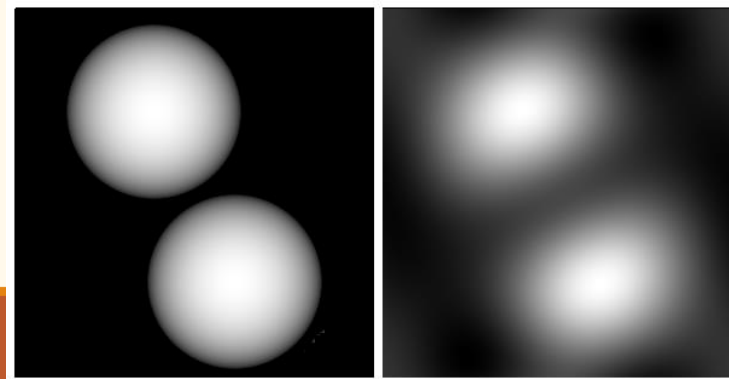
The main difference with single slit $\sin \theta = \frac{\lambda}{d}$ is the factor 1.22, which enters because of the circular shape of the aperture (not demonstrated).

$$\text{First minimum at: } \sin \theta = 1,22 \frac{\lambda}{d}$$

If one wants to image objects with **small angular separation**
diffraction = problem

*e.g. Two stars close to each other with a telescope
or two near micro-objects with a microscope*

*Expectation
(from geometrical optics)*



Reality

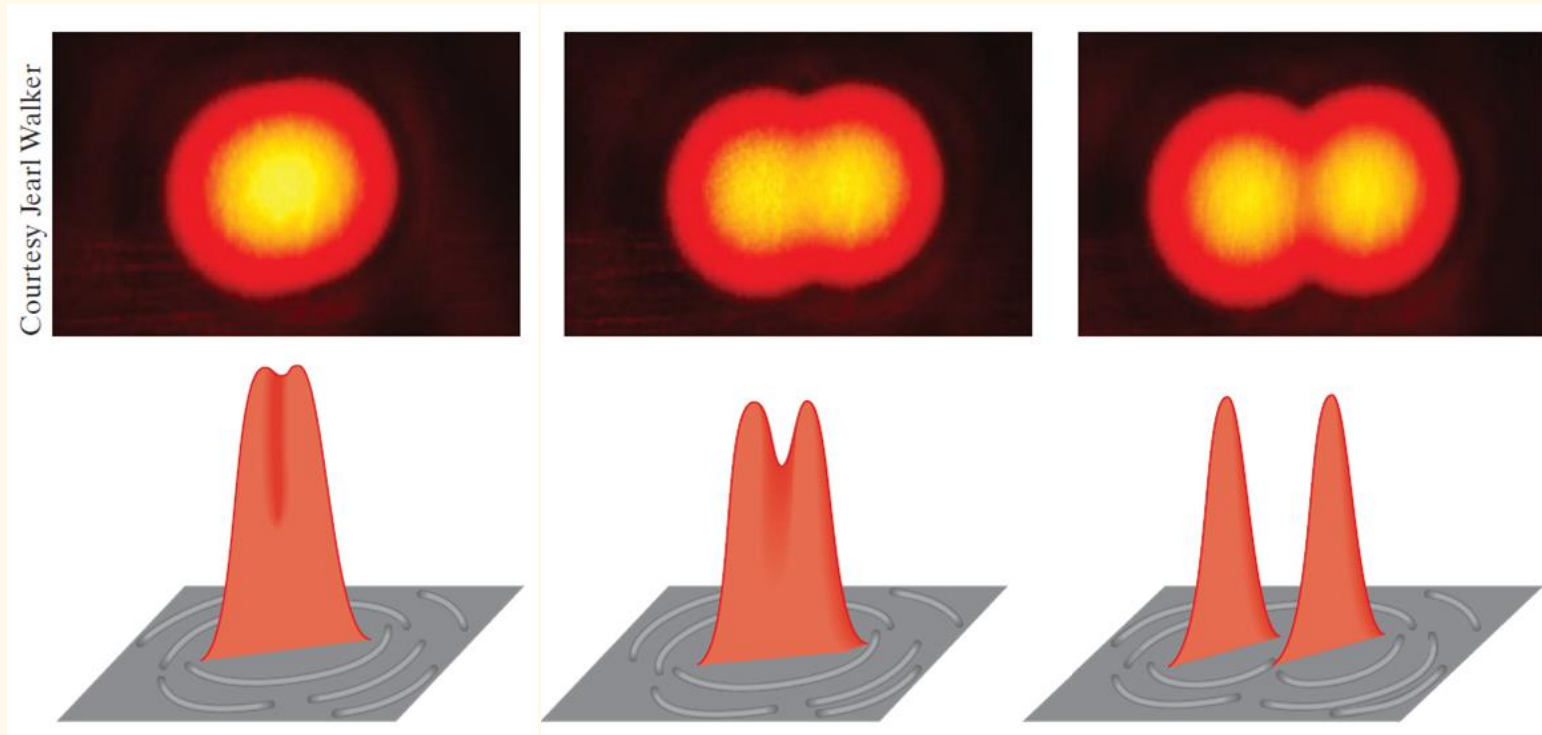
DIFFRACTION BY A CIRCULAR APERTURE

Resolvability

Closer are the objects, the more difficult they are to **resolve**

→ distinguish as 2 separate objects

Diffraction patterns overlap



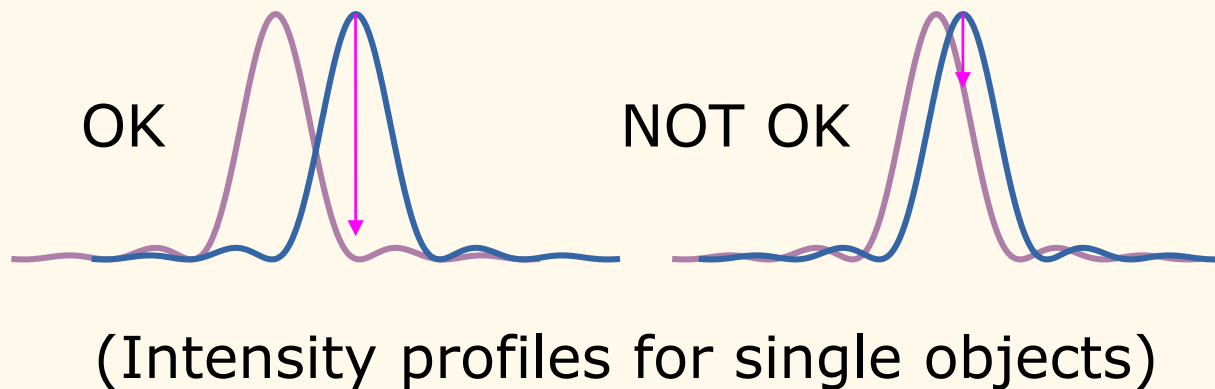
→ Need **objective criteria** to claim that we see two objects

DIFFRACTION BY A CIRCULAR APERTURE

Resolvability → **Rayleigh's criterion** (other criteria exist)

First minimum at: $\sin \theta = 1,22 \frac{\lambda}{d}$

Minimum condition to resolve 2 objects
when the 1st minimum of the 1st object
overlaps the maximum of the 2nd object



Since the angles are small, we
can replace $\sin \theta_R$ with θ_R

In other words, we define the
angular separation θ_R as:

$$\theta > \theta_R = 1,22 \frac{\lambda}{d}$$

The smallest angular separation
between two resolved objects

DIFFRACTION BY A CIRCULAR APERTURE

Resolvability → **Rayleigh's criterion** (other criteria exist)

Notes:

θ_R depends of the instrument

→ here d is for a single lens

→ if more lenses then more complex

θ_R depends of the wavelength

→ mean λ of visible light ~ 550 nm

→ smaller λ (e.g. UV < 400 nm) means smaller θ_R and better resolution

Valid for particles of smaller λ e.g. e^-
(quantum mechanics)

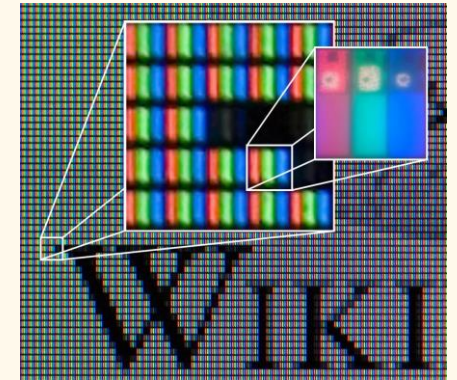
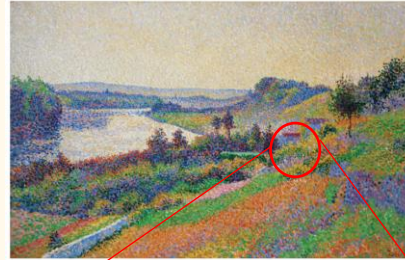
→ Scanning Electron Microscopy (SEM)

In other words, we define the angular separation θ_R as:

$$\theta > \theta_R = 1,22 \frac{\lambda}{d}$$

The smallest angular separation between two resolved objects

DIFFRACTION BY A CIRCULAR APERTURE



At normal viewing distances, the dots are irresolvable and thus blend.

DIFFRACTION BY A DOUBLE SLIT

So far, we investigated diffraction by **single objects**:

- single slit
- single circular aperture

What would happen if **several objects** diffract light ?

→ More interference !

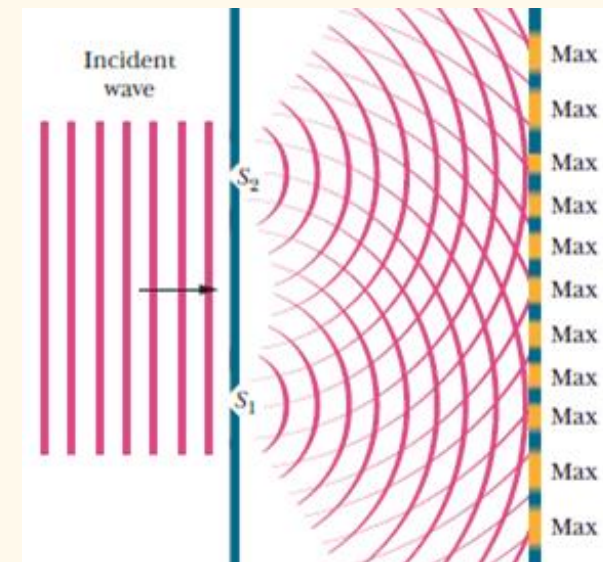
First, diffraction by **double slits of width not $\ll \lambda$**

When we studied interference by double-slits, we assumed $a \ll \lambda$

→ $a \ll \lambda$, so diffraction pattern \gg

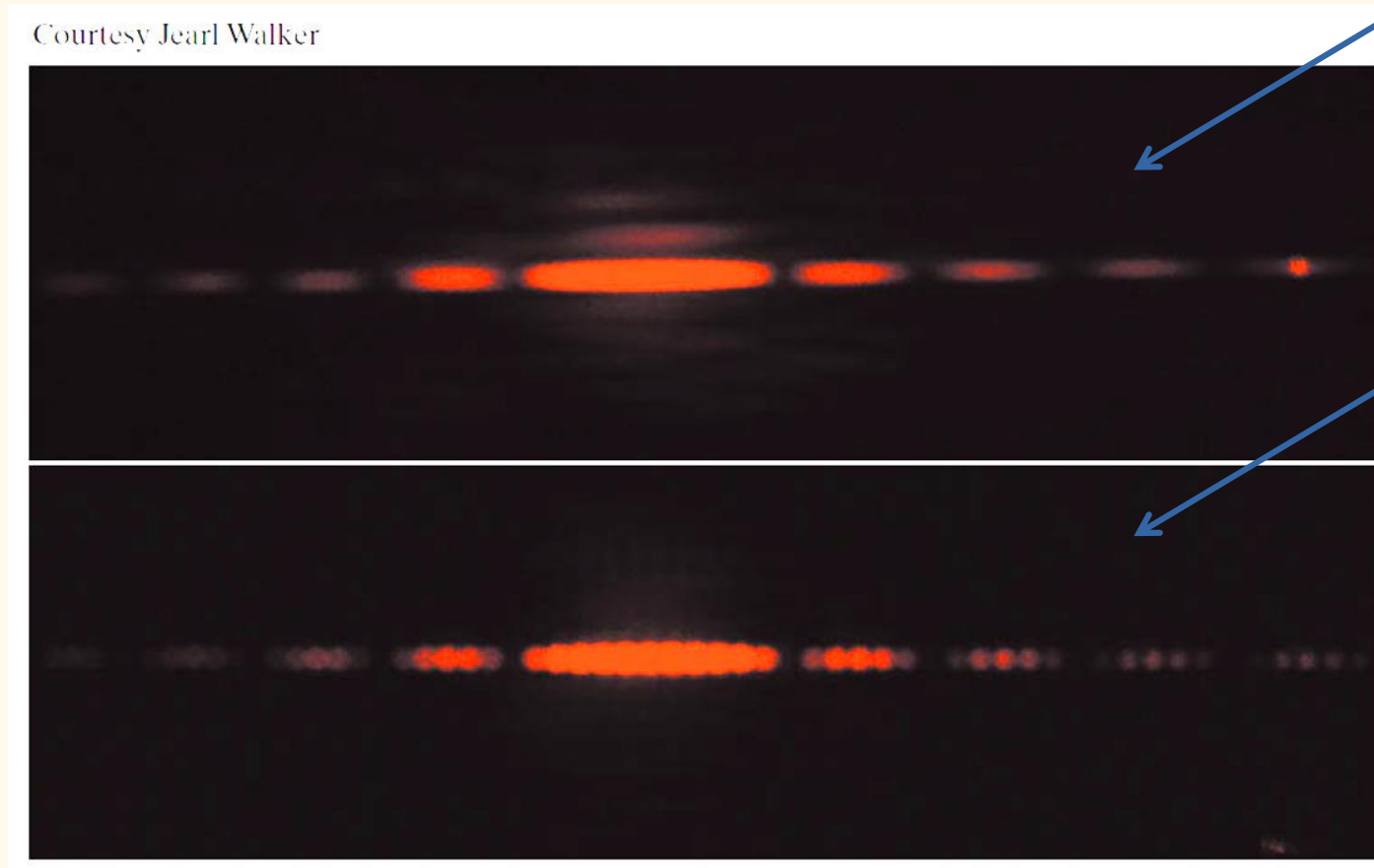
→ Interference on all the screen

Bright fringes with equal intensity



DIFFRACTION BY A DOUBLE SLIT

Typical experimental results:



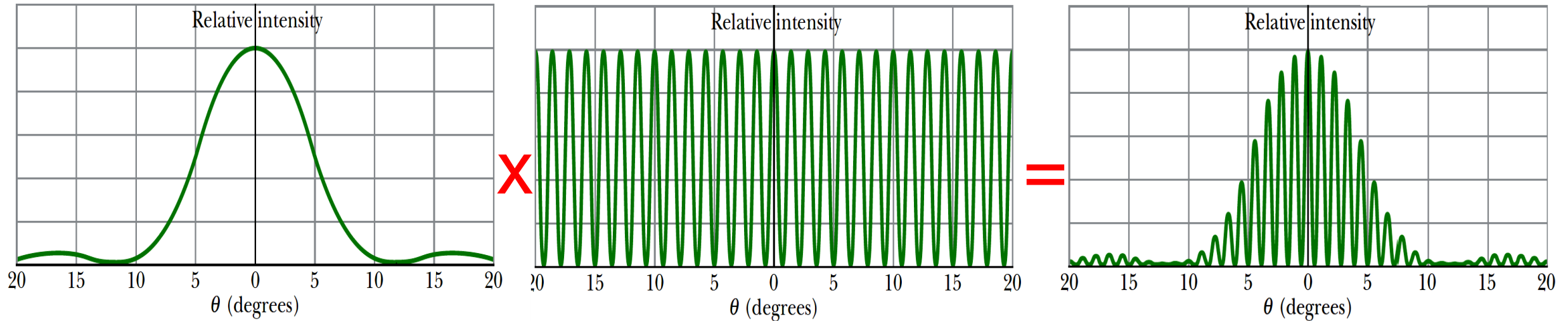
Single slit of width a :
" \sin_c^2 " pattern

**Double-slit of width a
spaced by distance d :**
" \sin_c^2 " pattern
multiplied by
" \cos^2 " pattern

→ " \cos^2 " is the interference
pattern of 2 slits

DIFFRACTION BY A DOUBLE SLIT

With graphs:



Diffraction pattern
of 1 slit ($a > \lambda$)

Interference pattern
of 2 slits ($a \sim \lambda$)
spaced by d

Diffraction pattern
of 2 slits ($a > \lambda$)
spaced by d

DIFFRACTION BY A DOUBLE SLIT

With equations:

$$I_{\theta} = I_m \cos^2 \left(\frac{d\pi}{\lambda} \sin \theta \right) \sin_c^2 \left(\frac{a\pi}{\lambda} \sin \theta \right)$$

Interference

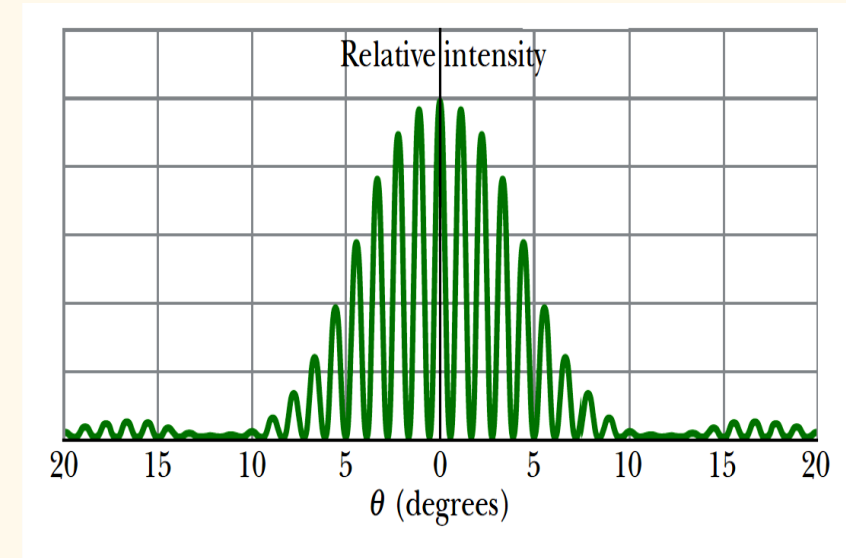
Diffraction

If $a \rightarrow 0$ then $\sin_c(\dots) \rightarrow 1$

Formula for double-slit ($a \ll \lambda$) interference

If $d \rightarrow 0$ then $\cos(\dots) \rightarrow 1$

Formula for single slit ($a > \lambda$) diffraction



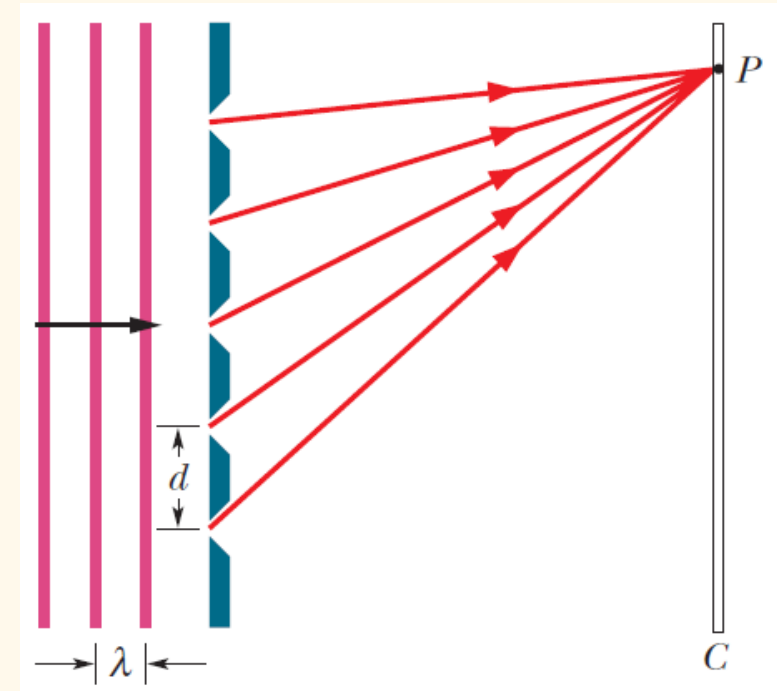
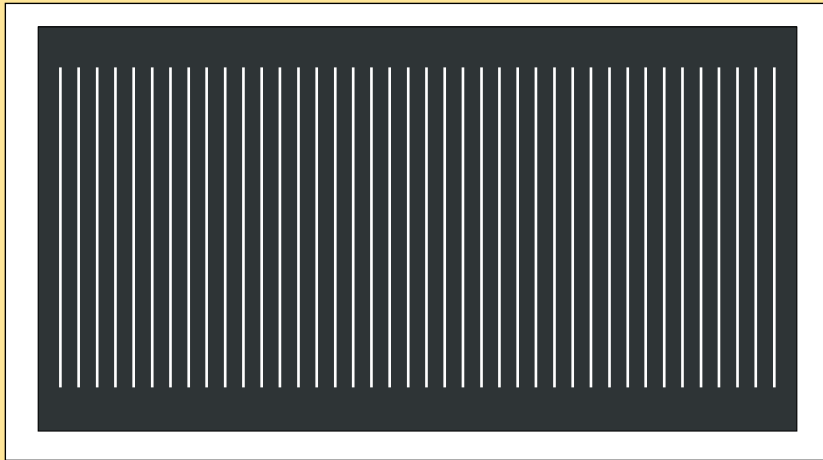
Diffraction pattern
of 2 slits ($a > \lambda$)
spaced by d

DIFFRACTION GRATINGS

Diffraction grating:

Alignment of **N (large number)** slits called **rulings** of **width** $\sim \lambda$ and spaced by $d > \lambda$

Width of the grating: $w = Nd$



Rulings $a \sim \lambda$ cause **interference**
Spacing $d > \lambda$ causes **diffraction**

DIFFRACTION GRATINGS

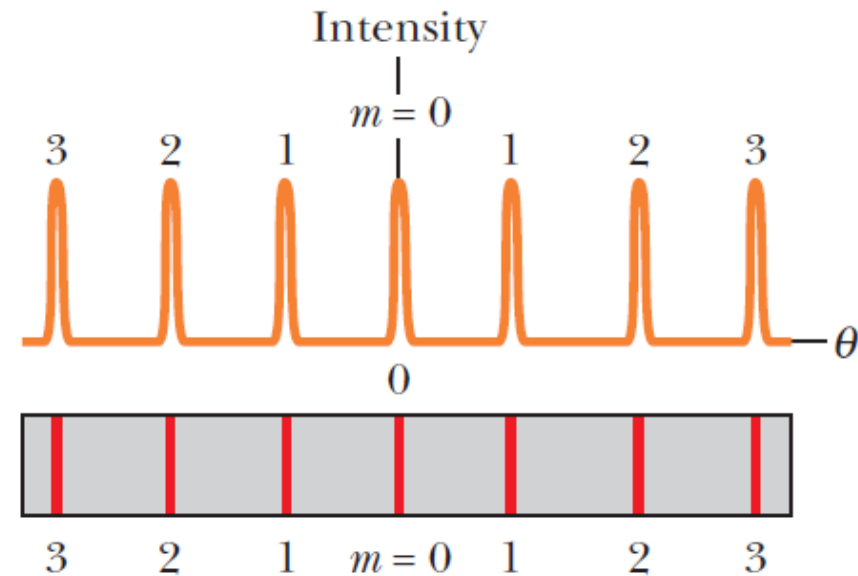
Diffraction grating:

Pattern for a monochromatic incident wave:

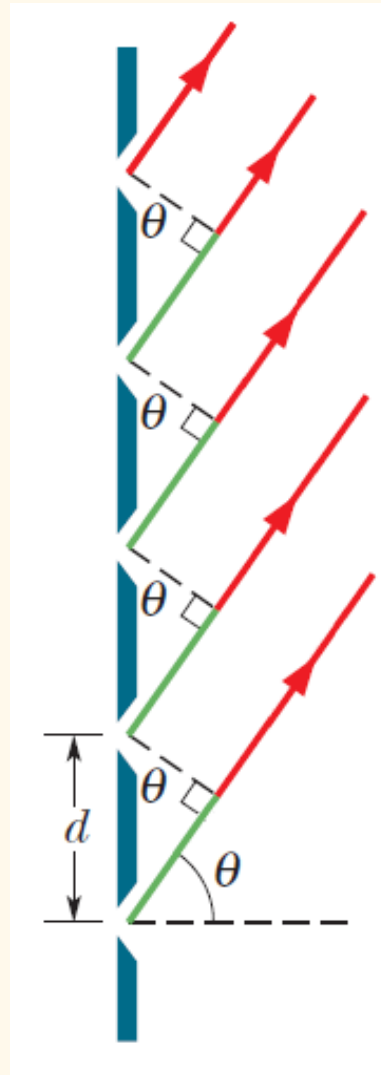
Very narrow maxima = **lines**
regularly spaced

Difference of path between adjacent rays: $d \sin \theta$

Constructive interference at lines
 $d \sin \theta = m \lambda$ (m integer)



Lines labeled by their order with respect to the central axis (angle θ)



DIFFRACTION GRATINGS

$$d \sin \theta = m\lambda \longrightarrow \theta = \arcsin \left(m \frac{\lambda}{d} \right)$$

Experimentally:

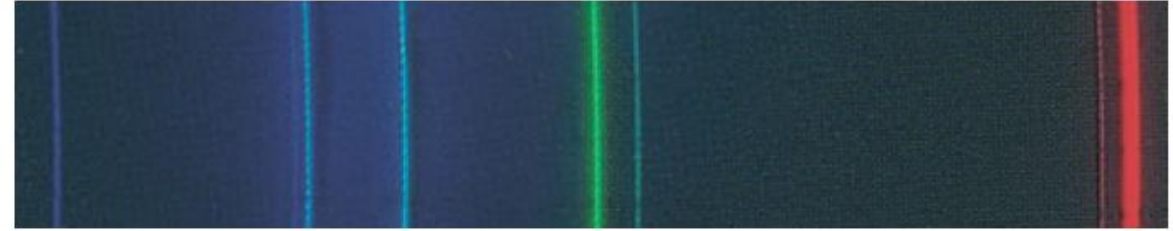
- We can measure θ & count m
- d is a known parameter

→ **Determining unknown λ**

Non-monochromatic incident light:

- Each λ produce a pattern of lines

→ **Separating and determining wavelengths**

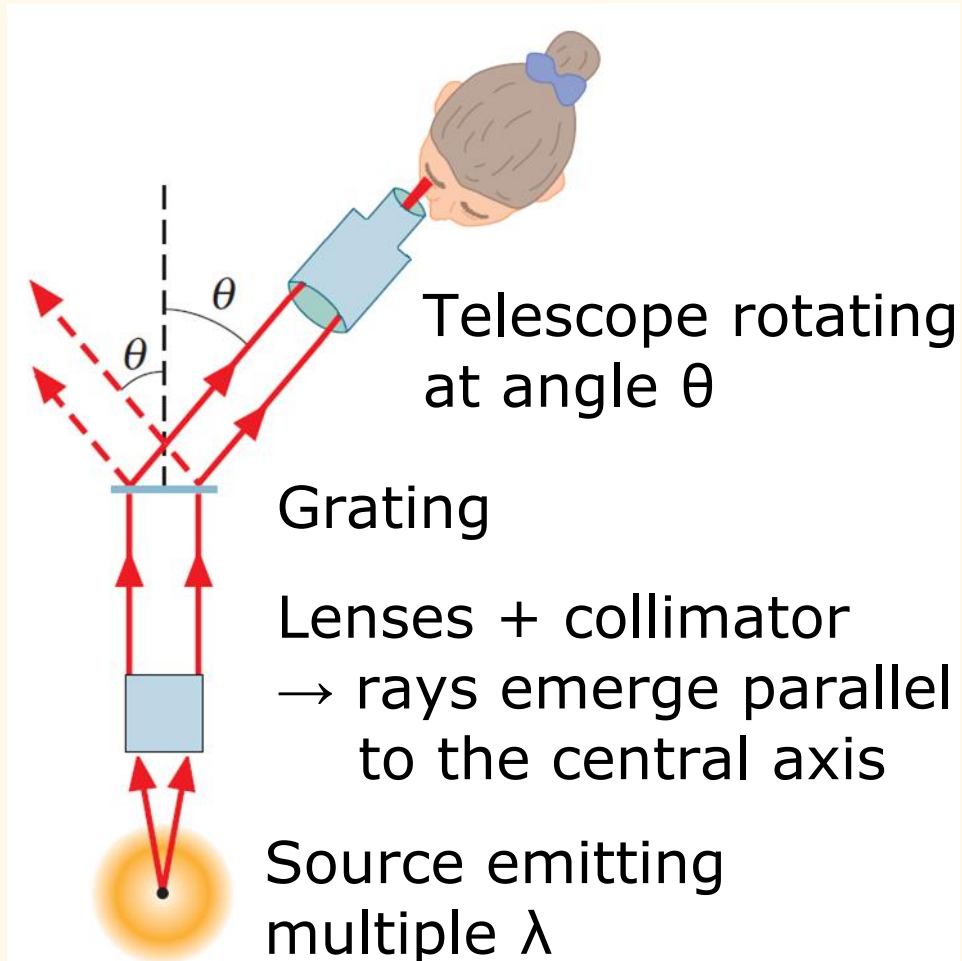


Department of Physics, Imperial College/Science Photo Library/
Photo Researchers, Inc.

Composition of an unknown sample emitting light can be determined with a **grating spectroscope**

DIFFRACTION GRATINGS

Grating spectroscope:

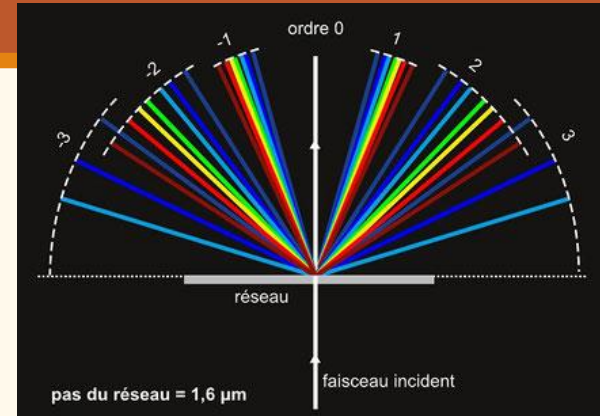
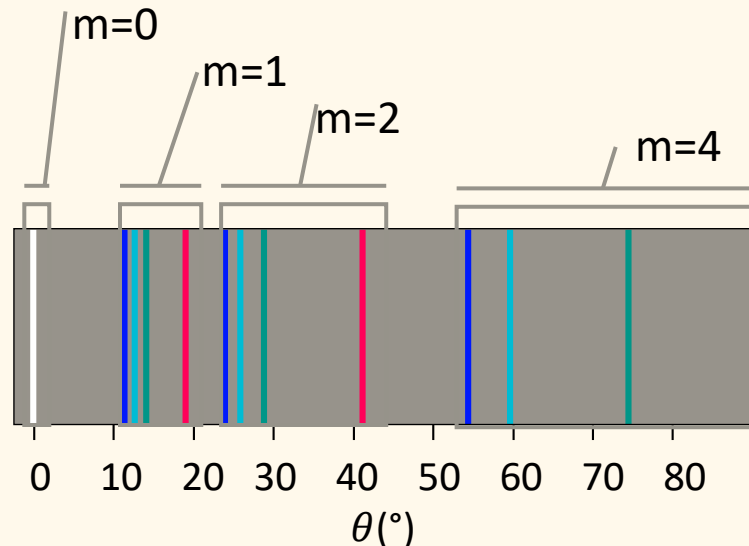


Example: Hydrogen lamp

→ Emits white light

→ Decomposed into multiple λ

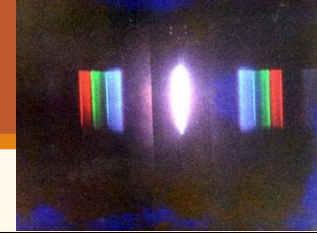
→ Emission lines



Notes:

- For $\theta = 0$ lines superposed
- $m = 3$ not shown for clarity
- 4th red line cannot be observed ($\theta > 90^\circ$)

DIFFRACTION GRATINGS



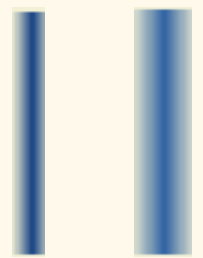
Grating spectroscope:

Lines must be clearly separated to be resolved:

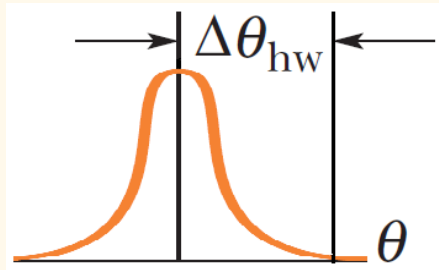
Bad



Good



We admit that the **half-width of a line** ($\Delta\theta_{hw}$) is:



N and d are characteristics of the grating

$$\Delta\theta_{hw} = \frac{\lambda}{Nd\cos\theta}$$

We define the **dispersion** (D) of the grating as:

$$D = \frac{\Delta\theta}{\Delta\lambda} = \frac{m}{d\cos\theta}$$

If $\Delta\lambda \ll$, D must be large to measure $\Delta\theta \geq \Delta\theta_{hw}$

DIFFRACTION GRATINGS

Grating spectroscope:

We define the **resolving power R** between two wavelength λ_1 & λ_2

$$\frac{m\Delta\lambda}{d\cos\theta} = \frac{\lambda}{N d\cos\theta}$$

$$R = \frac{1/2 (\lambda_1 + \lambda_2)}{\lambda_2 - \lambda_1} = \frac{\lambda_{avg}}{\Delta\lambda}$$

Since two lines are resolved if, at least : $\Delta\theta = \Delta\theta_{hw} = \frac{\lambda}{N d\cos\theta}$

Since: $D = \frac{\Delta\theta}{\Delta\lambda} = \frac{m}{d\cos\theta}$ We have: $\frac{\left(\frac{\lambda}{N d\cos\theta}\right)}{\Delta\lambda} = \frac{m}{d\cos\theta} \longrightarrow m N = \frac{\lambda}{\Delta\lambda}$

So $2m N = \frac{\lambda_1}{\Delta\lambda} + \frac{\lambda_2}{\Delta\lambda} \longrightarrow m N = \frac{1/2 (\lambda_1 + \lambda_2)}{\Delta\lambda} \longrightarrow R = m N$

DIFFRACTION GRATINGS

Grating spectroscope:

Resolving power R:

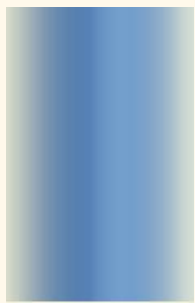
$$R = \frac{\lambda_{avg}}{\Delta\lambda} = m N$$

$R \gg \rightarrow$ Narrow lines

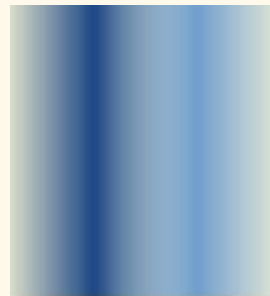
Dispersion D:

$$D = \frac{\Delta\theta}{\Delta\lambda} = \frac{m}{d \cos\theta}$$

$D \gg \rightarrow$ Spaced lines



⋮



⋮



⋮



$R \ll \& D \ll$

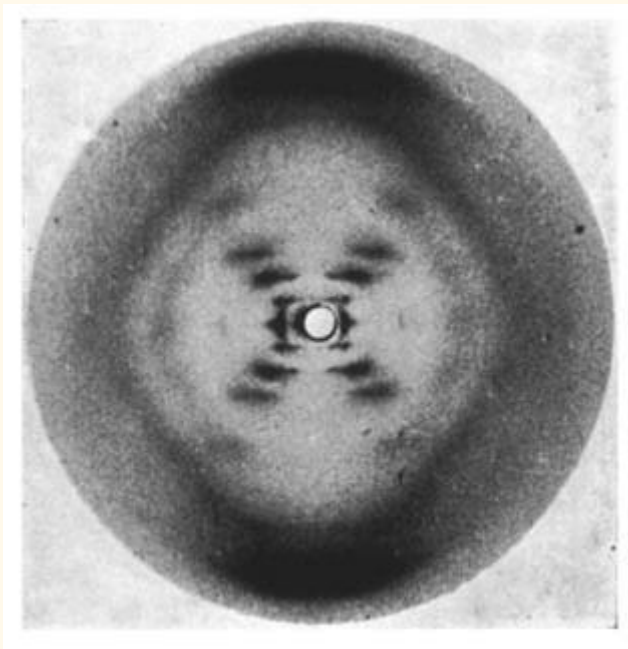
$R \ll \& D \gg$

$R \gg \& D \ll$

$R \gg \& D \gg$

X-RAY DIFFRACTION

Guess what I'm?



X-RAY DIFFRACTION



Rosalind Elsie Franklin (25 July 1920 – 16 April 1958) was a British chemist and X-ray crystallographer whose discovered the molecular structures of DNA

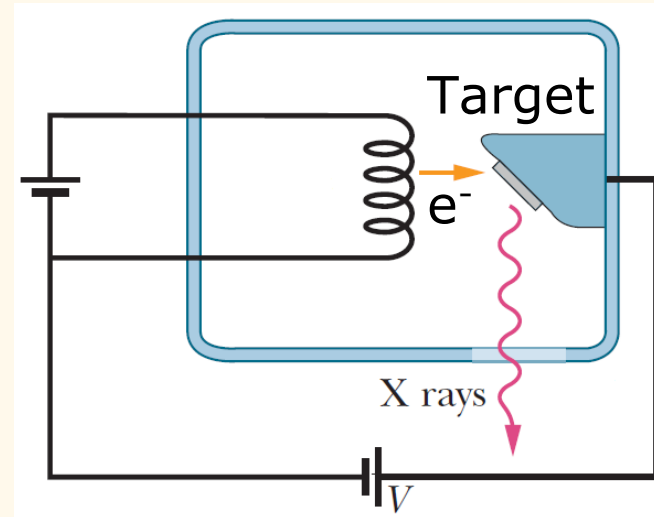
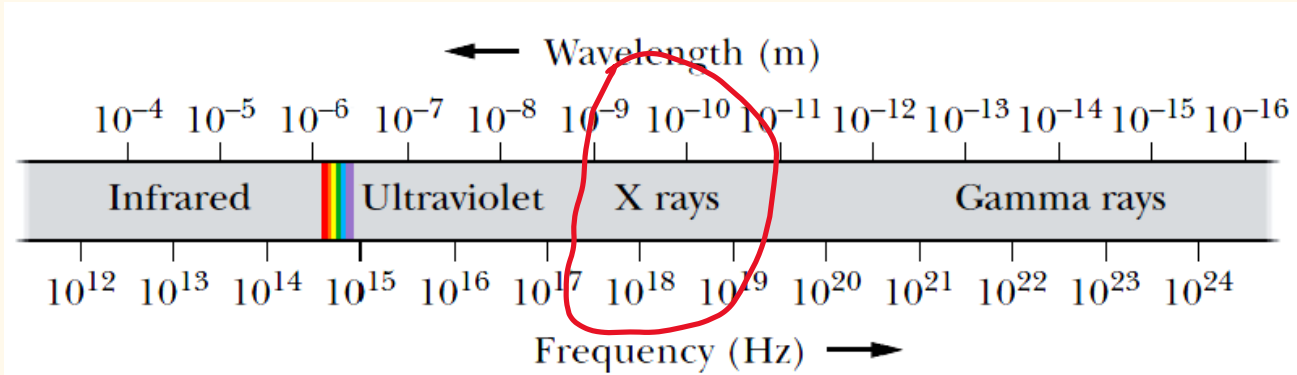
X-RAY DIFFRACTION

X-RAY: EM waves with $\lambda \ll$

$$\lambda \sim 0.1 \text{ nm} = 1 \text{ \AA}$$

Atoms in a metal target bombarded by accelerated e^- emits X-Rays

**/!\ X-rays are high energy radiation
→ must be handled with caution**



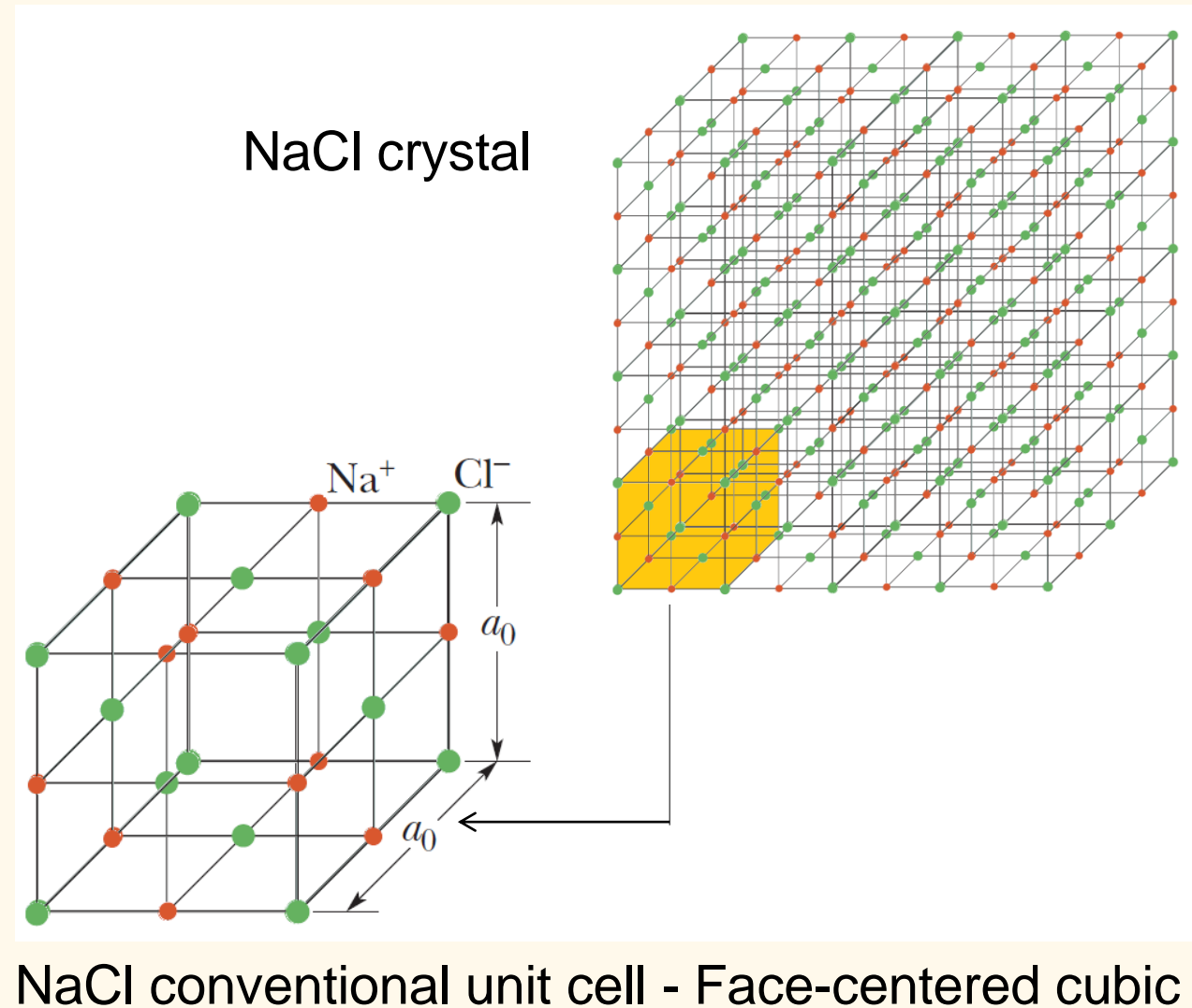
X-RAY DIFFRACTION

X-RAY: EM waves with $\lambda \ll$
 $\lambda \sim 0.1 \text{ nm} = 1 \text{ \AA}$

**Crystal = 3d translation of
the unit cell**

Inter-atomic distances in crystals
and atomic radius are small
enough to **diffract X-rays**

Crystal = 3d grating for x-rays



X-RAY DIFFRACTION

Note:

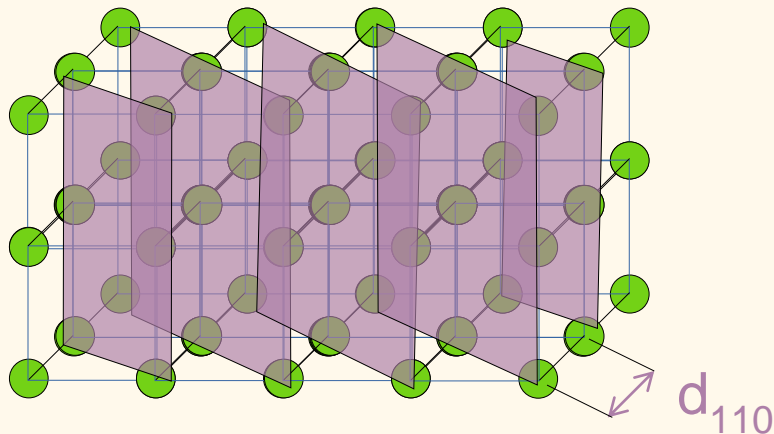
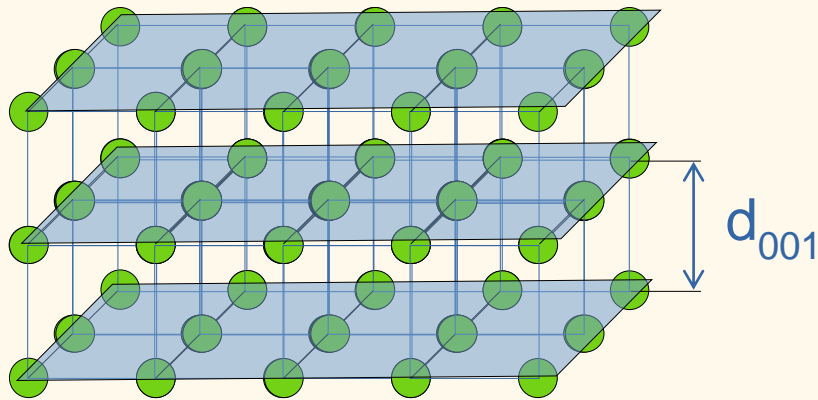
Previously, we explained how a **spectroscope** with a grating decompose **unknown radiation** to **determine wavelengths**
Grating parameters are known

For X-Ray diffraction by crystals **the situation is reversed:**
An **unknown crystal** diffracts radiation to **characterize the crystal**
 λ is known

We obtain information on the **geometry of the unit cell**, its **dimensions** and atomic **composition** from the diffraction pattern

X-RAY DIFFRACTION

X-rays **scattered** by the crystal structure → Redirected in all directions
Scattered waves interfere destructively or **constructively**



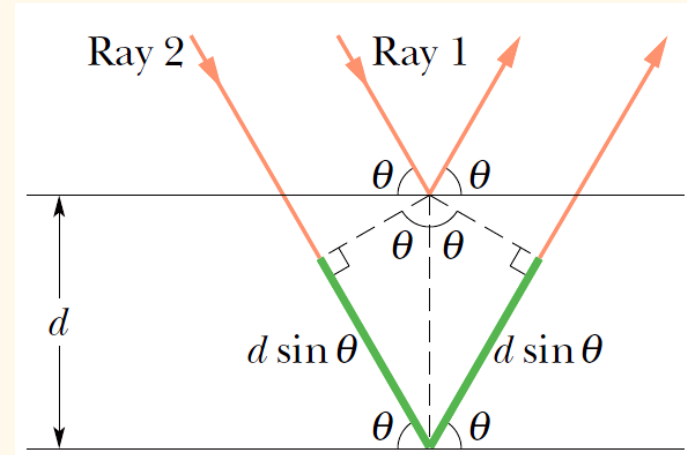
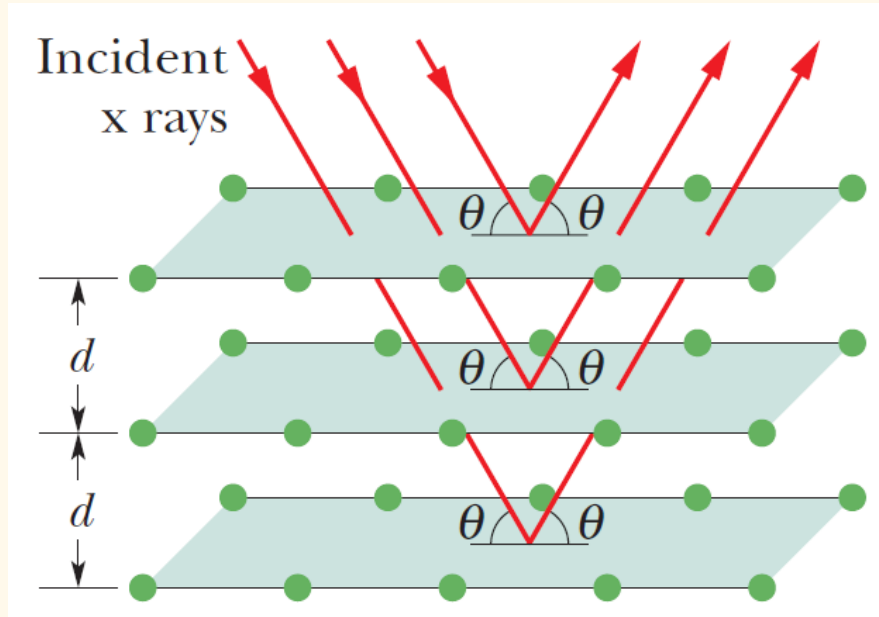
↓
Intensity maxima

As if X-Rays were **reflected** at angle θ
by a family of **parallel imaginary planes**
→ Identical (same atoms at the same positions)
→ spaced by a distance d

Example: two families of planes with
different interplanar distances

X-RAY DIFFRACTION

Intensity maxima when the reflected waves are in phase



Note: θ with respect to the plane here not the normal

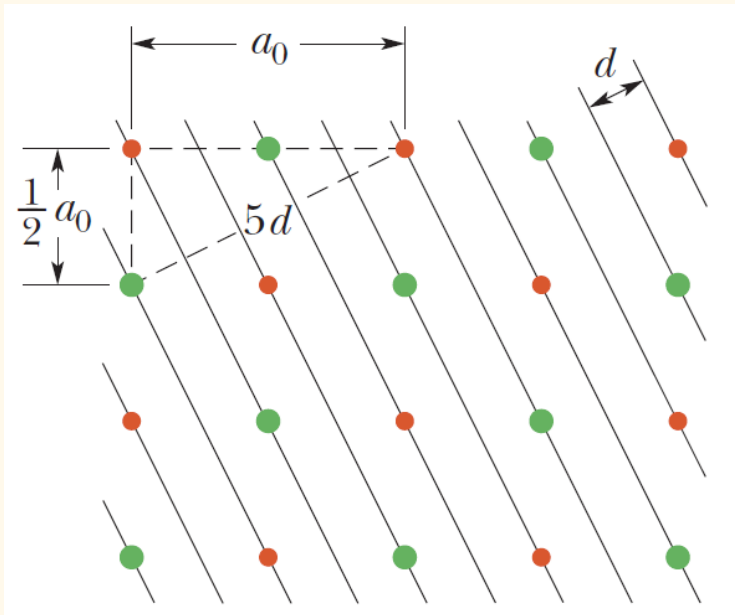
Difference of path length
 $2 d \sin \theta$

Bragg's law for intensity maxima: $2 d \sin \theta = m \lambda$

X-RAY DIFFRACTION

Intensity maxima when the reflected waves are in phase

Bragg's law for intensity maxima: $2 d \sin \theta = m \lambda$



Example of NaCl:

Diffraction pattern indicates face-centered cubic

Maxima of order m at angle θ

We have: $(5d)^2 = \left(\frac{a_0}{2}\right)^2 + a_0^2 \longrightarrow a_0 = d \sqrt{20}$

If I know λ and the angle θ formed on the screen between the 0th and the 1st order ($m=1$), I can know the interatomic distance

KEY POINTS

Single-slit diffraction $I_{\theta} = I_m \sin_c^2 \left(\frac{a\pi}{\lambda} \sin\theta \right)$

Diffraction by a circular aperture

Rayleigh's criteria $\theta_R = 1,22 \frac{\lambda}{d}$

Double-slit diffraction $I_{\theta} = I_m \cos^2 \left(\frac{d\pi}{\lambda} \sin\theta \right) \sin_c^2 \left(\frac{a\pi}{\lambda} \sin\theta \right)$

Diffraction gratings $d \sin \theta = m\lambda$ $R = \frac{\lambda_{avg}}{\Delta\lambda} = m N$ $D = \frac{\Delta\theta}{\Delta\lambda} = \frac{m}{d \cos\theta}$

Diffraction of X-rays by crystals and Bragg's law $2 d \sin\theta = m\lambda$

<https://www.youtube.com/watch?v=NazBRcMDOOo>

Diffraction interference patterns with phasor diagrams



Physics Videos by Eugene Khutoryansky ✓

973 k abonnés



Abonné



<https://youtu.be/cep6eECGtw4>

Why Does Light REALLY Bend?



The Science Asylum ✓

638 k abonnés

Re